

100V, 50A, 18.6mΩ N-channel Power SGT MOSFET

JMSL1018PK

Features

- $\bullet \;\;$ Excellent $R_{DS(ON)}$ and Low Gate Charge
- 100% UIS TESTED
- 100% ΔVds TESTED
- Halogen-free; RoHS-compliant

Applications

- Load Switch
- PWM Application
- Power Management

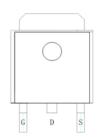
Product Summary

Parameters	Value	Unit
V_{DSS}	100	V
$V_{GS(th)_Typ}$	1.7	V
I _D (@V _{GS} =10V)	50	Α
$R_{DS(ON)_Typ}(@V_{GS}=10V$	13.4	mΩ
$R_{DS(ON)_Typ}(@V_{GS}=4.5V$	18.6	mΩ

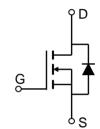








Pin Assignment



Schematic Diagram

Ordering Information

Device	Marking	MSL	Form	Package	Reel Size	Reel(pcs)	Per Carton (pcs)
JMSL1018PK	SL1018P	3	Tape&Reel	TO-252-3L	13"	2500	25000

Absolute Maximum Ratings (@ T_C = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit
V_{DS}	Drain-to-Source Voltage		100	V
V_{GS}	Gate-to-Source Voltage		±20	V
I _D	Continuous Drain Current	$T_C = 25^{\circ}C$	50	^
ıD	Continuous Diain Current	$T_C = 100$ °C	36	- A
I _{DM}	Pulsed Drain Current (1)		Refer to Fig.4	Α
E _{AS}	Single Pulsed Avalanche Energ	gy ⁽²⁾	74	mJ
P _D	Power Dissipation	$T_C = 25^{\circ}C$	82	W
' D	Fower Dissipation	$T_C = 100$ °C	33	v
T_{J}, T_{STG}	Junction & Storage Temperature	Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾ 39		°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.5	C/VV



Electrical Characteristics (T_J = 25°C unless otherwise specified)

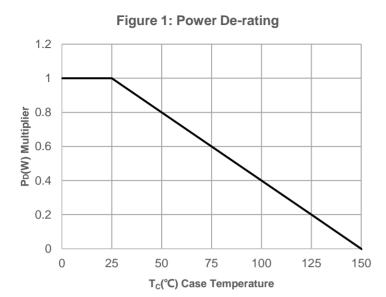
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	racteristics					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 80V, V_{GS} = 0V$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics	•			!	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2	1.7	2.2	V
О	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 10V, I_D = 20A$	-	13.4	17.4	mΩ
$R_{DS(ON)}$	Static Drain-Source ON-Resistance	$V_{GS} = 4.5V, I_D = 21A$	-	18.6	24.1	mΩ
Dynami	c Characteristics					
R_{g}	Gate Resistance	f = 1MHz	-	1.5	-	Ω
C_{iss}	Input Capacitance		-	992	-	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 50V,$ $f = 1MHz$	-	330	-	pF
C _{rss}	Reverse Transfer Capacitance		-	19.2	-	pF
Q_g	Total Gate Charge	V 0 40V	-	19	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 50V, I_{D} = 20A$	-	4	-	nC
Q_{gd}	Gate Drain("Miller") Charge	= V _{DS} = 50V, I _D = 20A	-	5	-	nC
				•		
Switchi	ng Characteristics			1	T	ı
t _{d(on)}	Turn-On DelayTime		-	7	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 50V$	-	18	-	ns
$t_{d(off)}$	Turn-Off DelayTime	I_{D} = 20A, R_{GEN} = 6.2 Ω	-	21	-	ns
t _f	Turn-Off Fall Time		-	9	-	ns
Body D	iode Characteristics					
Is	Maximum Continuous Body Diode Forward	Current	-	-	50	А
I_{SM}	Maximum Pulsed Body Diode Forward Curi	rent	-	-	201	Α
V_{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	1 200 di/dt 4000/	-	32	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 20A$, di/dt = 100A/us	-	32	-	nC

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- $2.\;E_{AS}\;condition:\;Starting\;T_{J}=25C,\;V_{DD}=50V,\;V_{G}=10V,\;R_{G}=25ohm,\;L=3mH,\;I_{AS}=7A,\;V_{DD}=0V\;during\;time\;in\;avalanche.$
- 3. $R_{\theta JA}$ is measured with the device mounted on a 1inch $^{\!2}$ pad of 2oz copper FR4 PCB.
- 4. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 0.5%.



Typical Performance Characteristics



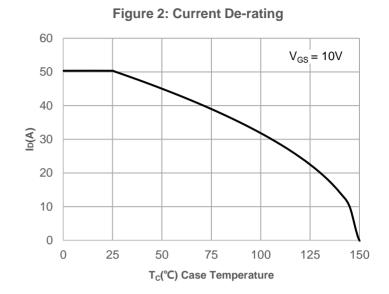
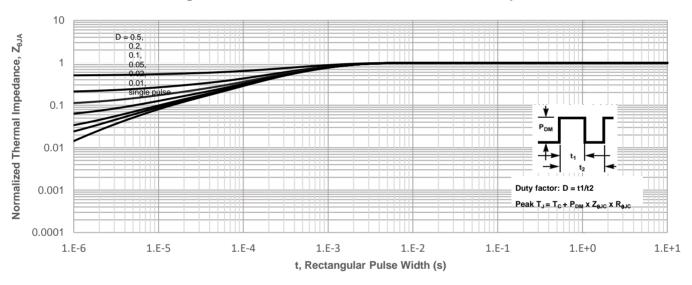
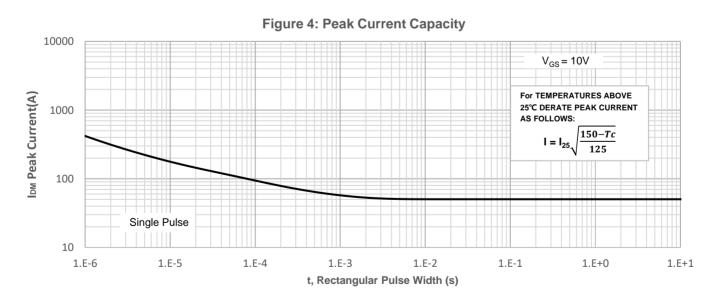


Figure 3: Normalized Maximum Transient Thermal Impedance







Typical Performance Characteristics

Figure 5: Output Characteristics

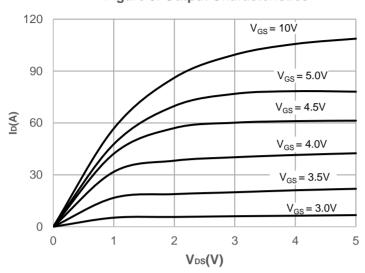


Figure 6: Typical Transfer Characteristics

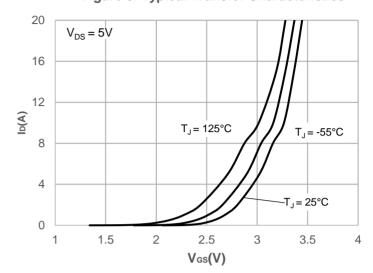


Figure 7: On-resistance vs. Drain Current

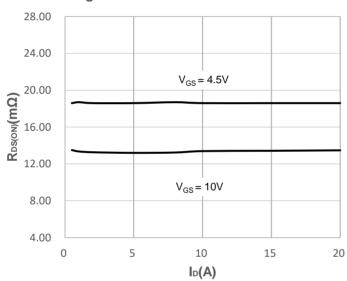


Figure 8: Body Diode Characteristics

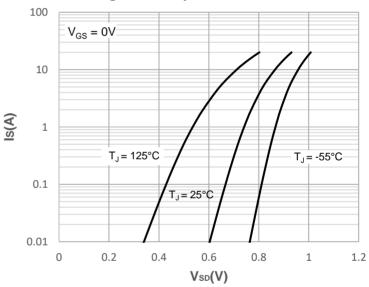


Figure 9: Gate Charge Characteristics

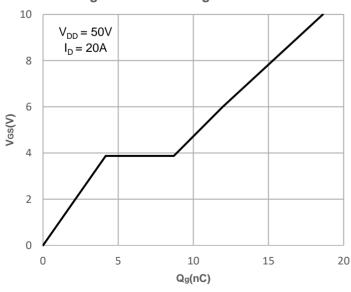
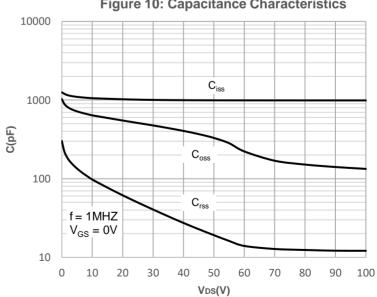


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

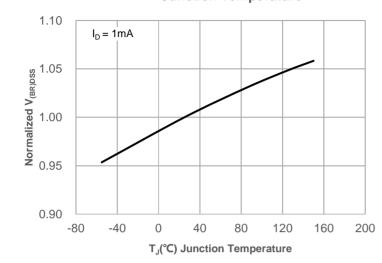


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

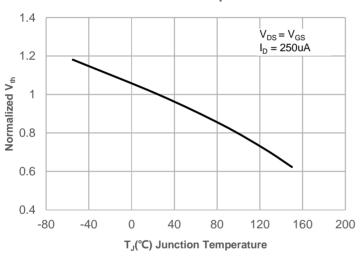


Figure 15: Maximum Safe Operating Area

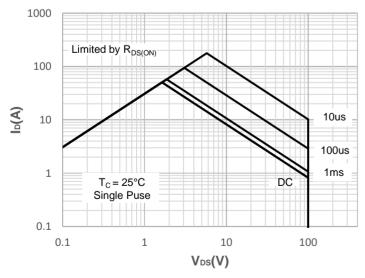
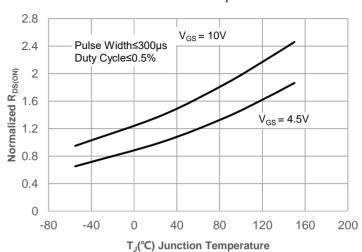
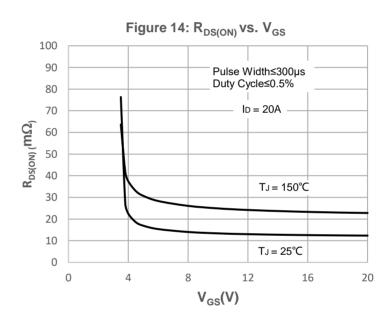


Figure 12: Normalized on Resistance vs. Junction Temperature







Test Circuit

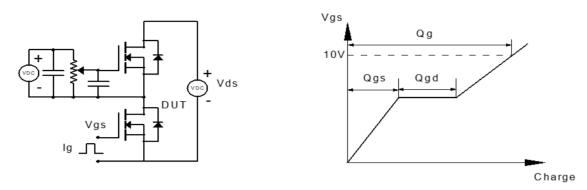


Figure 1: Gate Charge Test Circuit & Waveform

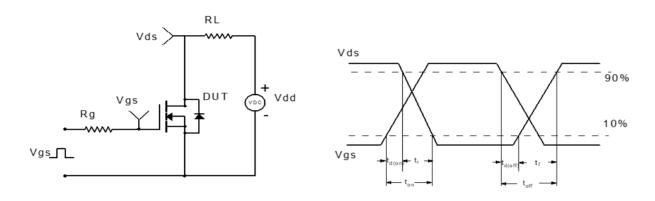


Figure 2: Resistive Switching Test Circuit & Waveform

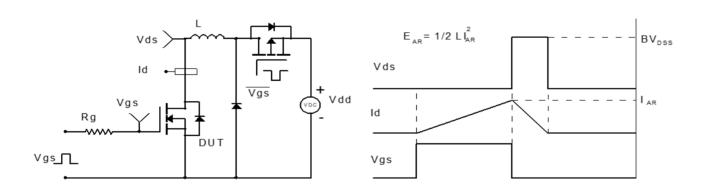


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

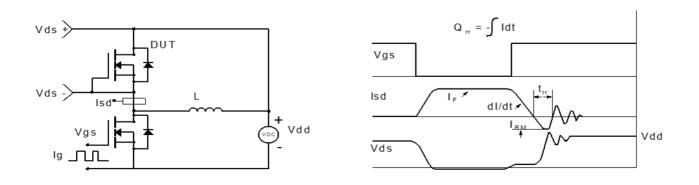
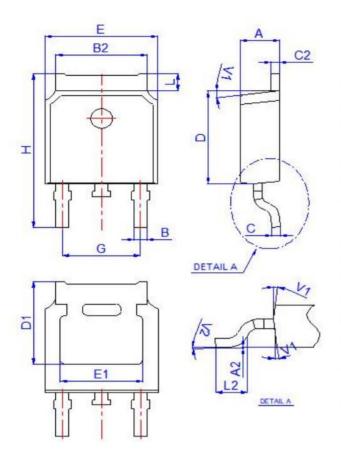


Figure 4: Diode Recovery Test Circuit & Waveform



Package Mechanical Data(TO-252-3L)



Ref.			Dime	ensions		
		Millimete	ers		Inches	
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
В	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
С	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
Н	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053	9)	0.065
V1		7°			7°	
V2	0°		6°	0°	7.	6°

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